

MOSFET – N-Channel QFET®

600 V, 0.3 A, 11.5 Ω

FQN1N60C

Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 0.3 A, 600 V, $R_{DS(on)} = 11.5 \Omega$ (Max.) @ $V_{GS} = 10 V$, $I_D = 0.15 A$
- Low Gate Charge (Typ. 4.8 nC)
- Low C_{rss} (Typ. 3.5 pF)
- 100% Avalanche Tested

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ C$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DSS}	Drain to Source Voltage	600	V
V_{GSS}	Gate to Source Voltage	± 30	V
I_D	Drain Current Continuous ($T_C = 25^\circ C$) Continuous ($T_C = 100^\circ C$)	0.3 0.18	A
I_{DM}	Drain Current – Pulsed (Note 1)	1.2	A
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	33	mJ
I_{AR}	Avalanche Current (Note 1)	0.3	A
E_{AR}	Repetitive Avalanche Energy (Note 1)	0.3	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
P_D	Power Dissipation ($T_A = 25^\circ C$) ($T_L = 25^\circ C$) Derate above $25^\circ C$	1 3 0.02	W W W/ $^\circ C$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$
T_L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	300	$^\circ C$

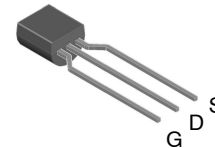
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. $L = 59 mH$, $I_{AS} = 1.1 A$, $V_{DD} = 50 V$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ C$.
3. $I_{SD} \leq 0.3 A$, $di/dt \leq 200 A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ C$.

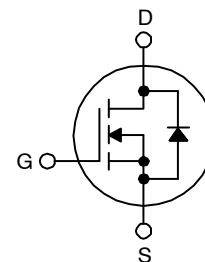


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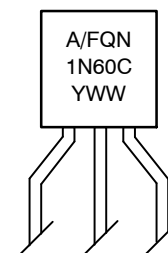
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TO-92 4.75x4.80
CASE 135AV



MARKING DIAGRAM



A = Assembly Site
FQN1N60C = Specific Device Code
Y = Year of Production
WW = Work Week Number

ORDERING INFORMATION

Device	Package	Shipping
FQN1N60CTA	TO-92 3LD	2000 / Fan-Fold

FQN1N60C

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JL}$	Thermal Resistance, Junction-to-Lead, Max. (Note 5)	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max. (Note 6)	140	

ELECTRICAL CHARACTERISTICS (T_C = 25°C, unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTIC						
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	600	-	-	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C	-	0.6	-	V/°C
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 600 V, V_{GS} = 0 V$	-	-	50	μA
		$V_{DS} = 480 V, T_C = 125^\circ C$	-	-	250	
I_{GSSF}	Gate to Body Leakage Current, Forward	$V_{GS} = 30 V, V_{DS} = 0 V$	-	-	100	nA
I_{GSSR}	Gate to Body Leakage Current, Reverse	$V_{GS} = -30 V, V_{DS} = 0 V$	-	-	-100	nA

ON CHARACTERISTICS

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	-	4.0	V
$R_{DS(on)}$	Static Drain to Source On-Resistance	$V_{GS} = 10 V, I_D = 0.15 A$	-	9.3	11.5	Ω
g_{FS}	Forward Transconductance	$V_{DS} = 40 V, I_D = 0.3 A$	-	0.75	-	S

DYNAMIC CHARACTERISTICS

C_{iss}	Input Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz$	-	130	170	pF
C_{oss}	Output Capacitance		-	19	25	pF
C_{rss}	Reverse Transfer Capacitance		-	3.5	6	pF

SWITCHING CHARACTERISTICS

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 300 V, I_D = 1.1 A, R_G = 25 \Omega$ (Note 4)	-	7	24	ns
t_r	Turn-On Rise Time		-	21	52	ns
$t_{d(off)}$	Turn-Off Delay Time		-	13	36	ns
t_f	Turn-Off Fall Time		-	27	64	ns
Q_g	Total Gate Charge	$V_{DS} = 480 V, I_D = 1.1 A, V_{GS} = 10 V$ (Note 4)	-	4.8	6.2	nC
Q_{gs}	Gate to Source Charge		-	0.7	-	nC
Q_{gd}	Gate to Drain Charge		-	2.7	-	nC

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

I_S	Maximum Continuous Drain to Source Diode Forward Current	-	-	0.3	A	
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	-	-	1.2	A	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 0.3 A$	-	-	1.4	V
t_{rr}	Reverse Recovery Time	$V_{GS} = 0 V, I_S = 1.1 A, di_F/dt = 100 A/\mu s$	-	190	-	ns
Q_{rr}	Reverse Recovery Charge		-	0.53	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Essentially independent of operating temperature.
- Reference point of the $R_{\theta JL}$ is the drain lead.
- When mounted on 3"x4.5" FR-4 PCB without any pad copper in a still air environment ($R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance. $R_{\theta CA}$ is determined by the user's board design)

TYPICAL CHARACTERISTICS

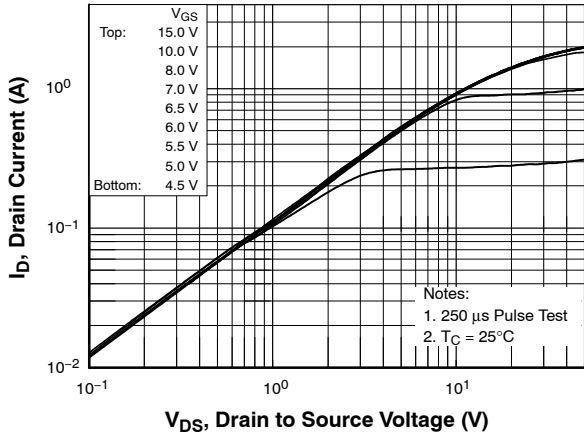


Figure 1. On-Region Characteristics

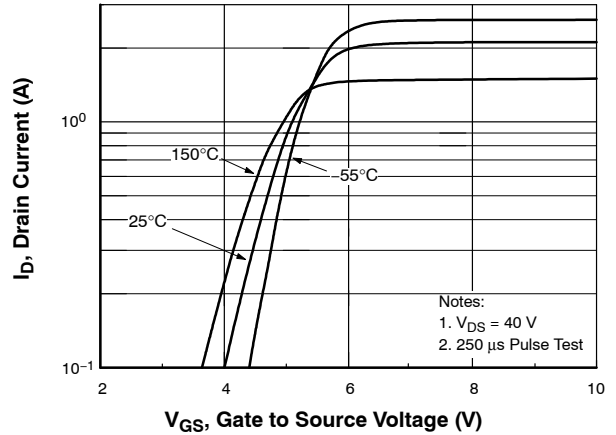


Figure 2. Transfer Characteristics

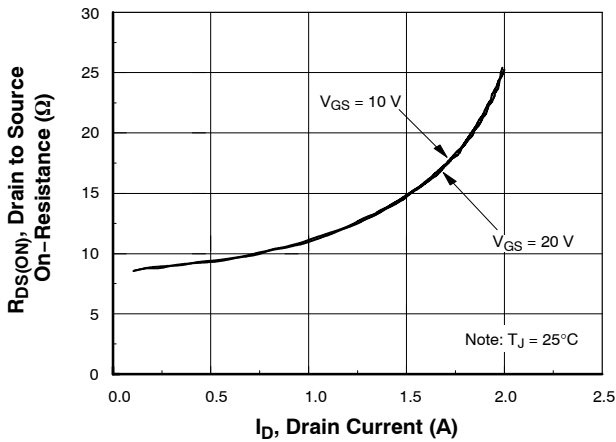


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

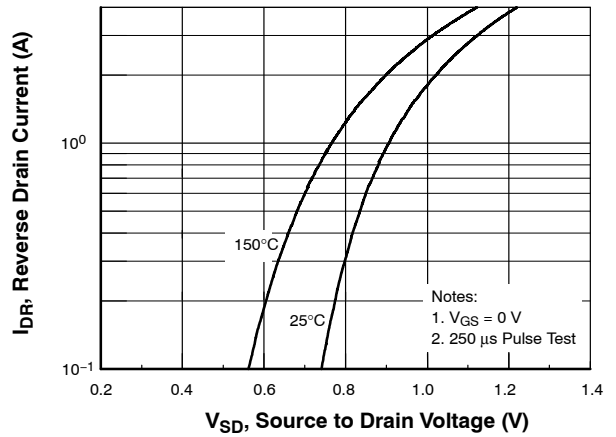


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

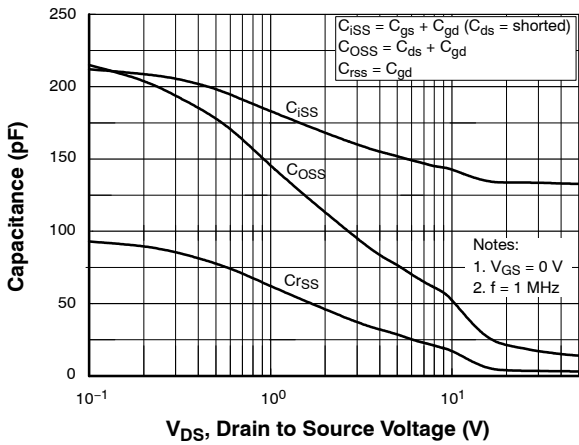


Figure 5. Capacitance Characteristics

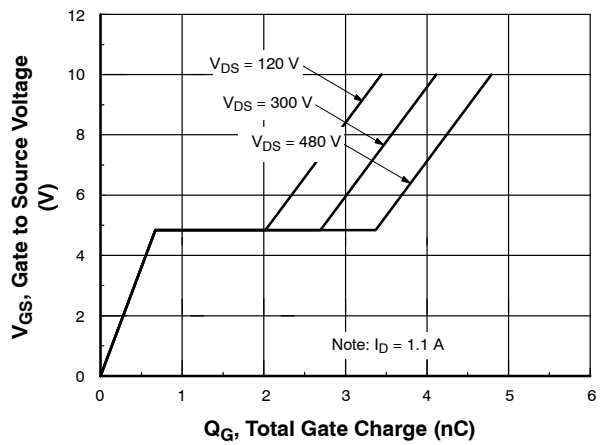


Figure 6. Gate Charge Characteristics

FQN1N60C

TYPICAL CHARACTERISTICS (Continued)

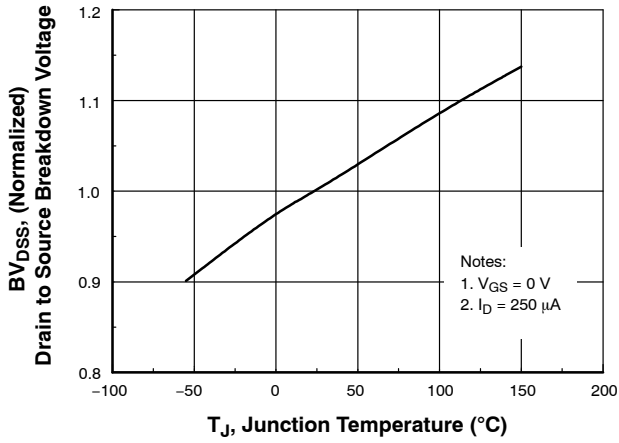


Figure 7. Breakdown Voltage Variation vs. Temperature

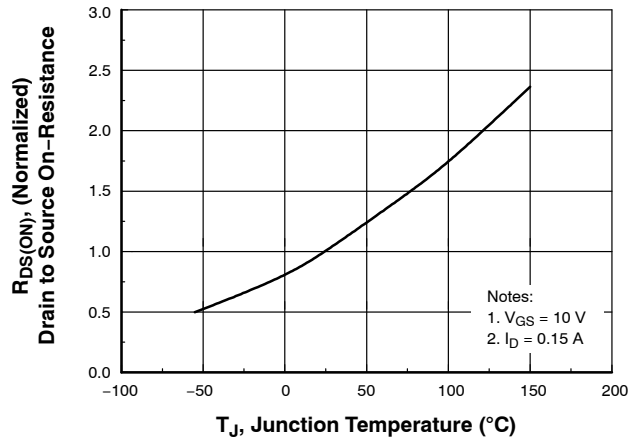


Figure 8. On-Resistance Variation vs. Temperature

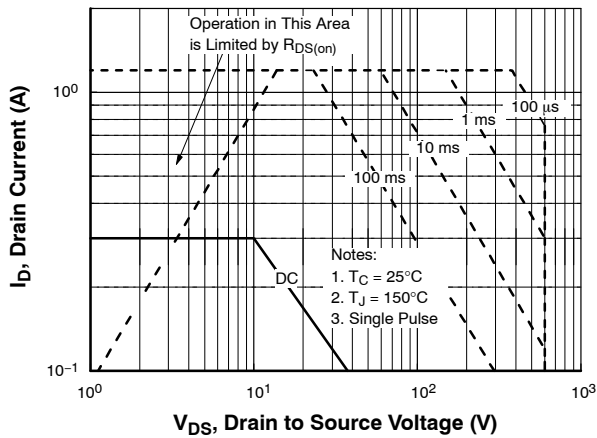


Figure 9. Maximum Safe Operating Area

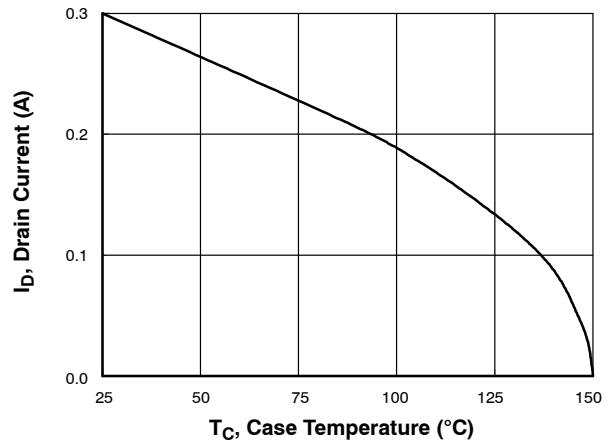


Figure 10. Maximum Drain Current vs. Case Temperature

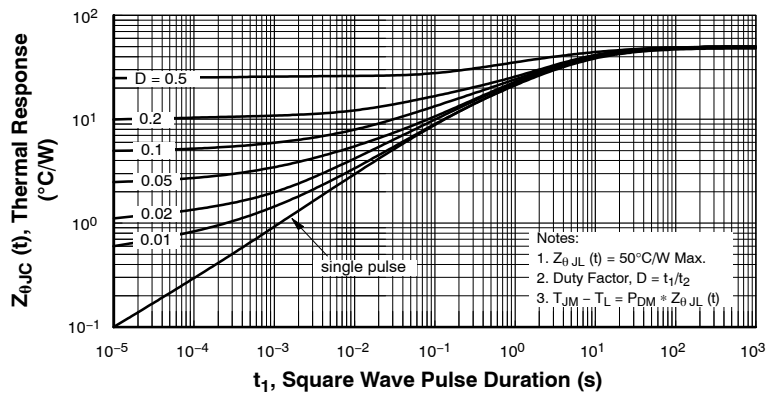


Figure 11. Transient Thermal Response Curve

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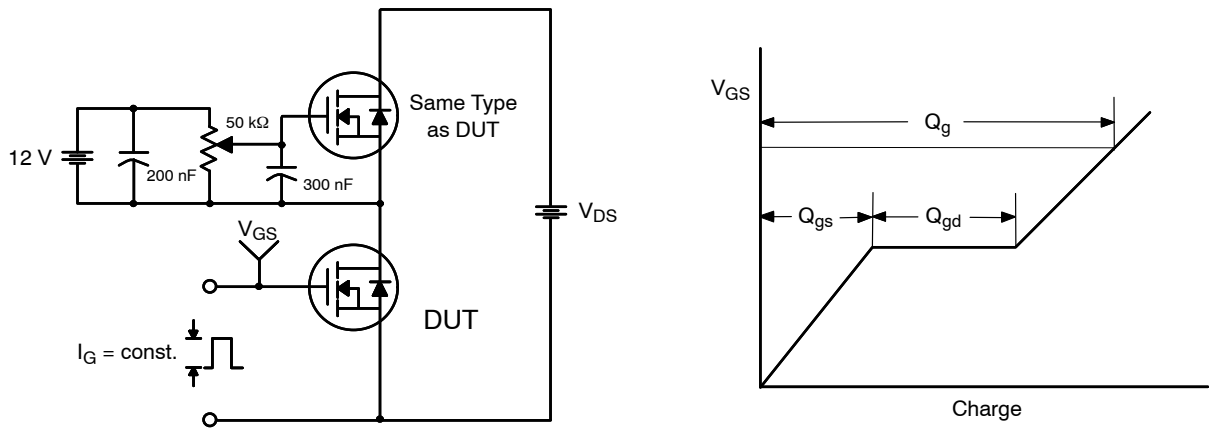


Figure 12. Gate Charge Test Circuit & Waveform

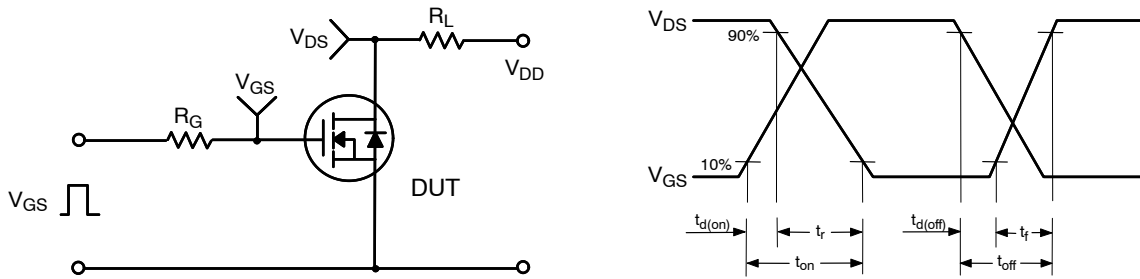


Figure 13. Resistive Switching Test Circuit & Waveforms

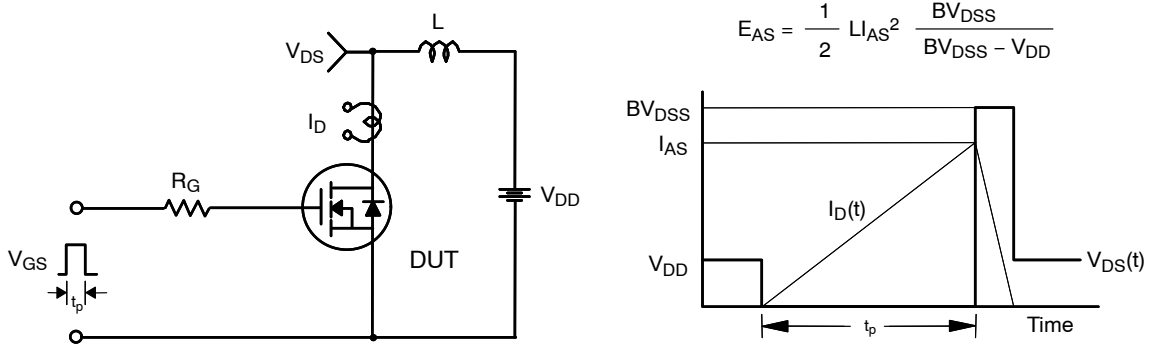


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

FQN1N60C

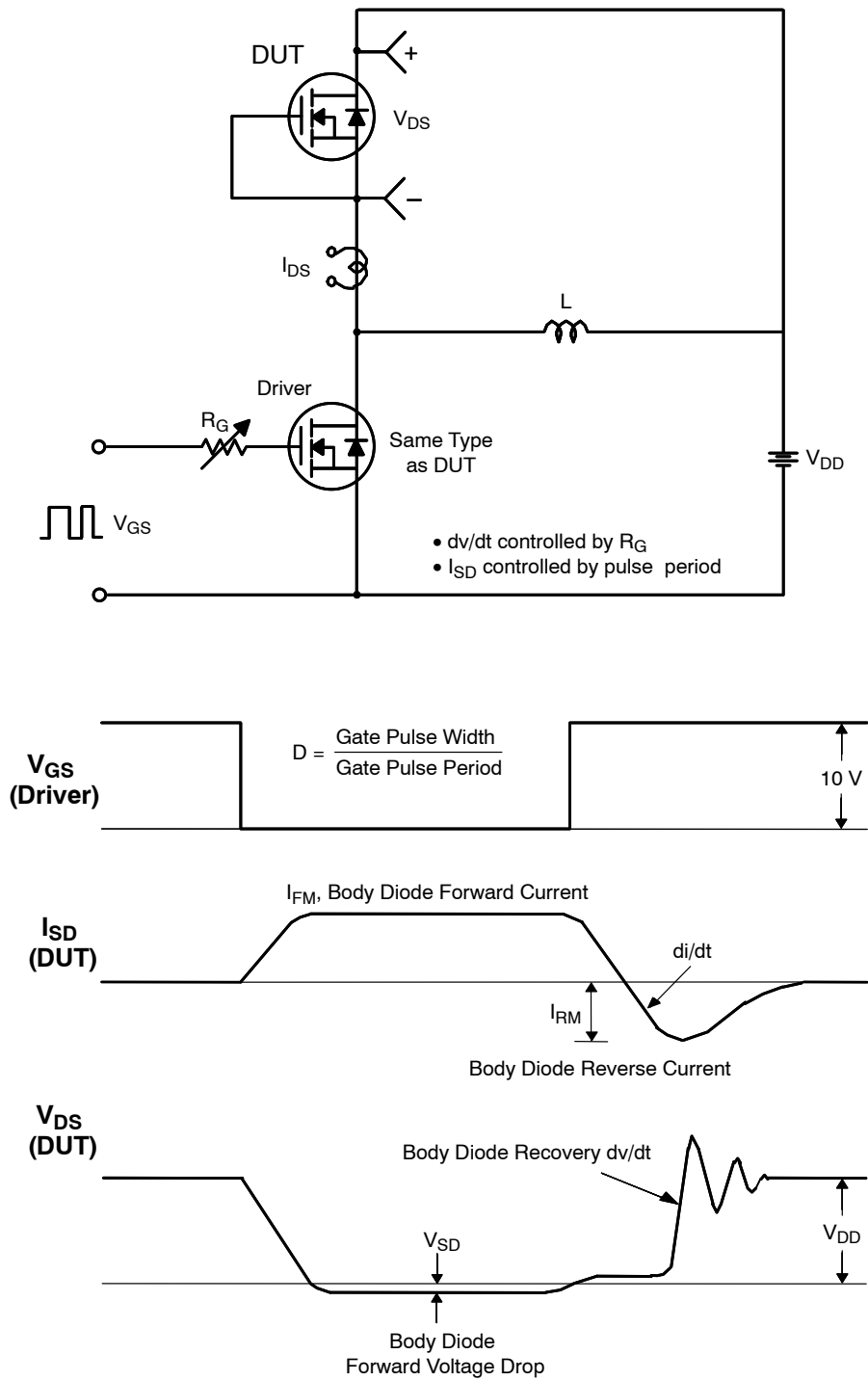
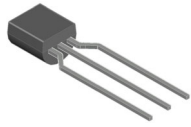


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

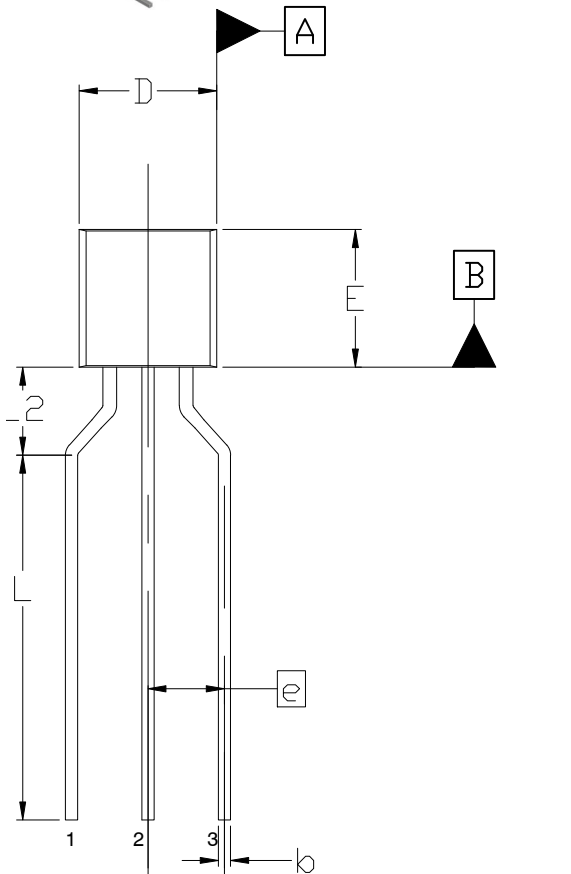
MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

ON Semiconductor®

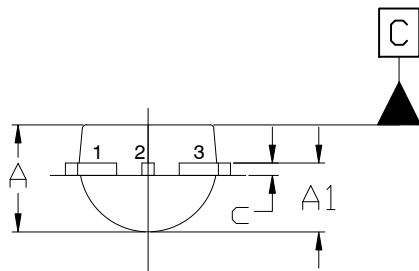


TO-92 3LD 4.75x4.80
CASE 135AV
ISSUE O

DATE 07 JAN 2021



TOP VIEW



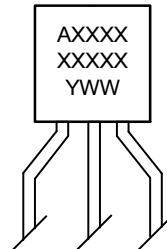
END VIEW

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, GATE REMAINS AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	3.05	3.60	4.19
A1	2.13	2.50	2.88
b	0.36	0.46	0.56
c	0.30	0.40	0.52
D	4.32	4.75	5.20
E	4.32	4.80	5.33
e	2.54 BSC		
L	10.50	11.75	13.00
L2	2.54	---	3.44

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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